TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VHC174F,TC74VHC174FN,TC74VHC174FT

Hex D-Type Flip Flop with Clear

The TC74VHC174 is an advanced high speed CMOS HEX D-TYPE FLIP FLOP fabricated with silicon gate C²MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

Information signals applied to D inputs are transferred to the Q output on the positive going edge of the clock pulse.

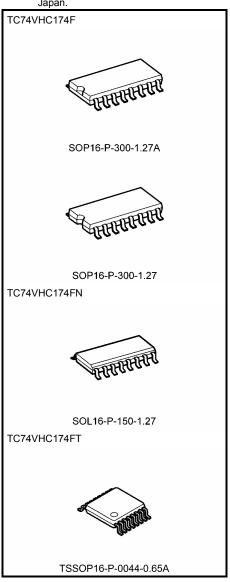
When the \overline{CLR} input is held low, the Q output are in the low logic level independent of the other inputs.

An input protection circuit ensures that 0 to 5.5 V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5 to 3 V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

Features

- High speed: $f_{max} = 150 \text{ MHz}$ (typ.) at $V_{CC} = 5 \text{ V}$
- Low power dissipation: $I_{CC} = 4 \mu A$ (max) at $T_{a} = 25$ °C
- High noise immunity: V_{NIH} = V_{NIL} = 28% V_{CC} (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays: $t_{pLH} \simeq t_{pHL}$
- Wide operating voltage range: VCC (opr) = 2 to 5.5 V
- Low noise: VOLP = 0.8 V (max)
- Pin and function compatible with 74ALS174

Note: xxxFN (JEDEC SOP) is not available in Japan.



Weight

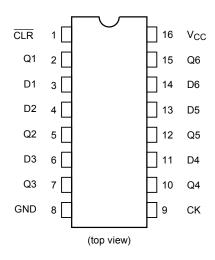
 SOP16-P-300-1.27A
 : 0.18 g (typ.)

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 : 0.18 g (typ.)

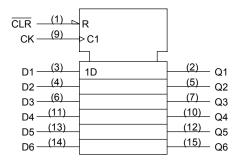
 SOL16-P-150-1.27
 : 0.13 g (typ.)

 TSSOP16-P-0044-0.65A
 : 0.06 g (typ.)

Pin Assignment



IEC Logic Symbol

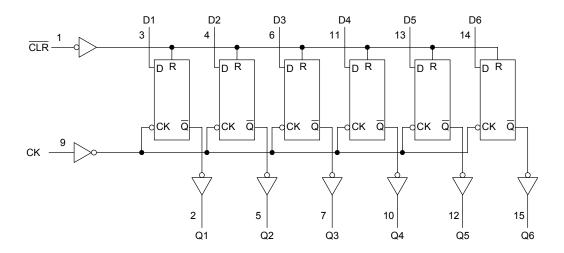


Truth Table

	Inputs		Output	Function		
CLR	CLR D CK		Q	Tunction		
L	Х	Χ	L	Clear		
Н	L		L	_		
Н	Н		Н	_		
Н	Х	\neg	Qn	No Change		

X: Don't care

System Diagram





Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC}	−0.5 to 7.0	V
DC input voltage	V _{IN}	−0.5 to 7.0	V
DC output voltage	V _{OUT}	-0.5 to V _{CC} + 0.5	V
Input diode current	I _{IK}	-20	mA
Output diode current	lok	±20	mA
DC output current	lout	±25	mA
DC V _{CC} /ground current	Icc	±50	mA
Power dissipation	P_{D}	180	mW
Storage temperature	T _{stg}	−65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Recommended Operating Conditions (Note)

Characteristics	Symbol	Rating	Unit	
Supply voltage	V _{CC}	2.0 to 5.5	V	
Input voltage	V _{IN}	0 to 5.5	V	
Output voltage	V _{OUT}	0 to V _{CC}	V	
Operating temperature	T _{opr}	-40 to 85	°C	
Input rise and fall time	dt/dv	0 to 100 (V _{CC} = 3.3 ± 0.3 V)	ns/V	
input rise and fair time	ui/uv	0 to 20 (V _{CC} = 5 ± 0.5 V)	HS/V	

Note: The recommended operating conditions are required to ensure the normal operation of the device.

Unused inputs must be tied to either VCC or GND.



Electrical Characteristics

DC Characteristics

Characteristics	Symbol	Test Condition			Ta = 25°C			Ta = −40 to 85°C		Unit
Orial actoristics	Gymbol				Min	Тур.	Max	Min	Max	Onic
High-level input voltage	V _{IH}	_			1.50 V _{CC} × 0.7	1 1		1.50 V _{CC} × 0.7	1 1	V
Low-level input voltage	V _{IL}	_		2.0 3.0 to 5.5			0.50 V _{CC} × 0.3		0.50 V _{CC} × 0.3	٧
High-level output voltage	V _{ОН}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -50 μA	2.0 3.0 4.5	1.9 2.9 4.4	2.0 3.0 4.5	_ _ _	1.9 2.9 4.4	1 1 1	٧
			$I_{OH} = -4 \text{ mA}$ $I_{OH} = -8 \text{ mA}$	3.0 4.5	2.58 3.94	-	_ _	2.48 3.80	_ _	
Low-level output voltage	V _{OL} =	V _{IN} = V _{IH} or	I _{OL} = 50 μA	2.0 3.0 4.5		0.0 0.0 0.0	0.1 0.1 0.1	_ _ _	0.1 0.1 0.1	V
		V _{IL}	I _{OL} = 4 mA I _{OL} = 8 mA	3.0 4.5		_ _	0.36 0.36	_ _	0.44 0.44	
Input leakage current	I _{IN}	V _{IN} = 5.5 V or GND		0 to 5.5	_	_	±0.1	_	±1.0	μA
Quiescent supply current	Icc	V _{IN} = V _C	_C or GND	5.5	_	_	4.0	_	40.0	μΑ

Timing Requirements (input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol	Test Condition	Condition		Ta = 25°C		Unit
			V _{CC} (V)	Тур.	Limit	Limit	
Minimum pulse width	t _{w (L)}		3.3 ± 0.3	_	5.0	5.0	
(CK)	t _{w (H)}	_	5.0 ± 0.5	_	5.0	5.0	ns
Minimum pulse width			3.3 ± 0.3	_	5.0	5.0	
(CLR)	t _{w (L)}	_	5.0 ± 0.5	_	5.0	5.0	ns
Minimum act un timo		_	3.3 ± 0.3	_	5.0	6.0	no
Minimum set-up time	t _s		5.0 ± 0.5	_	4.5	4.5	ns
Minimum hold time	4.		3.3 ± 0.3	_	0.0	0.0	no
Willimitati noid time	t _h	_	5.0 ± 0.5	_	0.5	0.5	ns
Minimum removal time			3.3 ± 0.3	_	3.0	3.0	no
(CLR)	t _{rem}	_	5.0 ± 0.5	_	2.5	2.5	ns



AC Characteristics (input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Te Symbol		st Condition		Ta = 25°C			Ta = −40 to 85°C		Unit
	•		V _{CC} (V)	C _L (pF)	Min	Тур.	Max	Min	Max	
			3.3 ± 0.3	15	_	7.2	11.0	1.0	13.0	ns
Propagation delay time	t_{pLH}			50	_	9.7	14.5	1.0	16.5	
(CK-Q)	t_{pHL}		5.0 ± 0.5	15	_	4.9	7.2	1.0	8.5	
			5.0 ± 0.5	50	_	6.4	9.2	1.0	10.5	
			3.3 ± 0.3	15	_	7.4	11.4	1.0	13.5	- ns
Propagation delay time	t _{pHL}			50	_	9.9	14.9	1.0	17.0	
(CLR -Q)			5.0 ± 0.5	15	_	5.1	7.6	1.0	9.0	
,				50	_	6.6	9.6	1.0	11.0	
	f _{max}	_	3.3 ± 0.3	15	95	150	_	80	_	- MHz
Maximum clock				50	55	85	_	50	_	
frequency			5.0 ± 0.5	15	130	175	_	110	_	
				50	90	120	_	80	_	
Output to output skew	t _{osLH}	(Note 1)	3.3 ± 0.3	50	_	_	1.5	_	1.5	ne
Output to output skew	t _{osHL}	(Note 1)	5.5 ± 0.5	50	_	_	1.0	_	1.0	ns
Input capacitance	C _{IN}		_		_	4	10	_	10	pF
Power dissipation capacitance	C _{PD}			(Note 2)	_	29	_	_	_	pF

Note 1: Parameter guaranteed by design.

$$t_{OSLH} = |t_{DLHm} - t_{DLHn}|, t_{OSHL} = |t_{DHLm} - t_{DHLn}|$$

Note 2: CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/6 (per F/F)$$

And the total C_{PD} when n pcs. of flip flop operate can be gained by the follwing eguation:

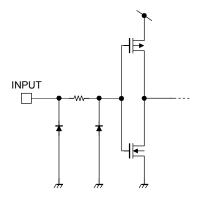
$$C_{PD}$$
 (total) = 19 + 10·n

Noise Characteristics (input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol	Test Condition		Ta = 25°C		Unit
Characteristics	Symbol		V _{CC} (V)	Тур.	Max	Offic
Quiet output maximum dynamic V _{OL}	V _{OLP}	C _L = 50 pF	5.0	0.4	0.8	V
Quiet output minimum dynamic V _{OL}	V _{OLV}	C _L = 50 pF	5.0	-0.4	-0.8	V
Minimum high level dynamic input voltage	V _{IHD}	C _L = 50 pF	5.0	_	3.5	V
Maximum low level dynamic input voltage	V_{ILD}	C _L = 50 pF	5.0	_	1.5	V



Input Equivalent Circuit



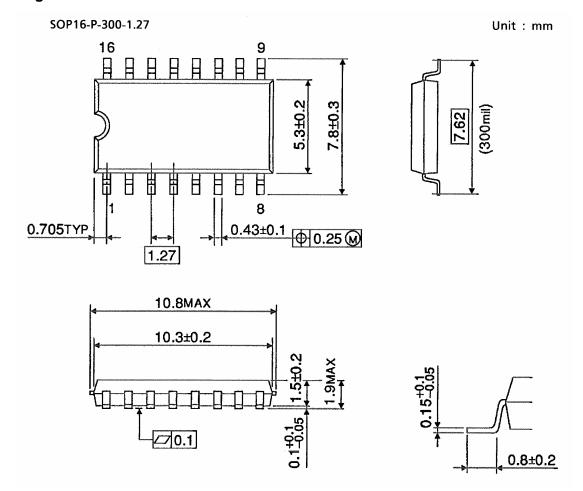
Package Dimensions

SOP16-P-300-1.27A Unit: mm 5.3 ± 0.2 7.8 ± 0.3 8 1.27 0.705TYP 10.8MAX $0.15^{+0.075}_{-0.035}$ 10.3 ± 0.2 0.25 0.8 ± 0.2 1.5±0.2 1.9MAX □ 0.1

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Weight: 0.18 g (typ.)

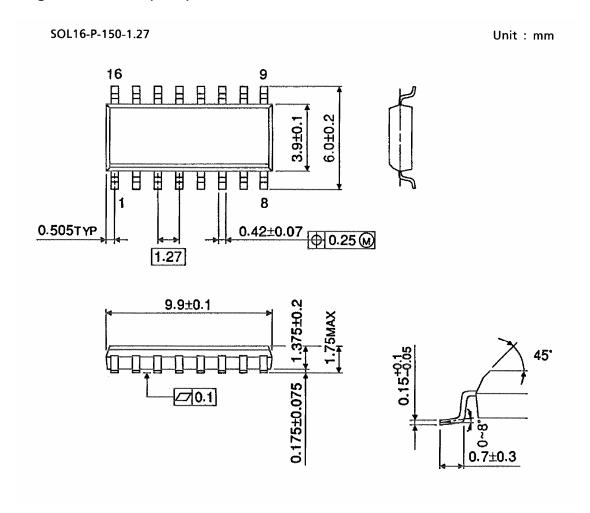
Package Dimensions



Weight: 0.18 g (typ.)



Package Dimensions (Note)

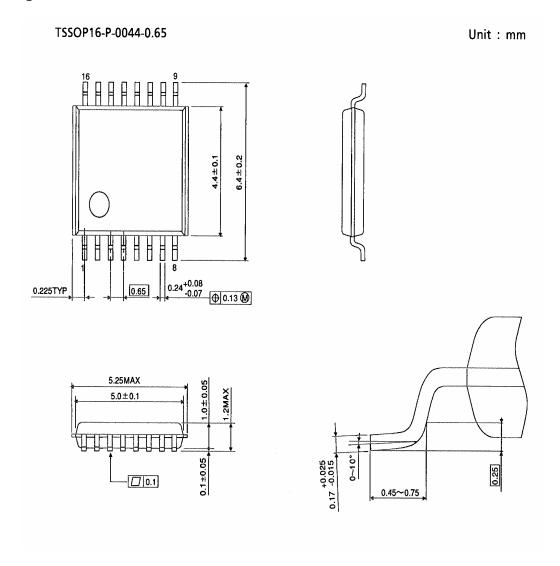


Note: This package is not available in Japan.

Weight: 0.13 g (typ.)



Package Dimensions



Weight: 0.06 g (typ.)

Note: Lead (Pb)-Free Packages

SOP16-P-300-1.27A SOL16-P-150-1.27 TSSOP16-P-0044-0.65A

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